

2048-pixel CCD Linear Sensor (B/W)

Description

The ILX551B is a reduction type CCD linear sensor designed for facsimile, image scanner and OCR use. This sensor reads B4 size documents at a density of 200DPI (Dot Per Inch). A built-in timing generator and clock-drivers ensure direct drive at 5V logic for easy use.

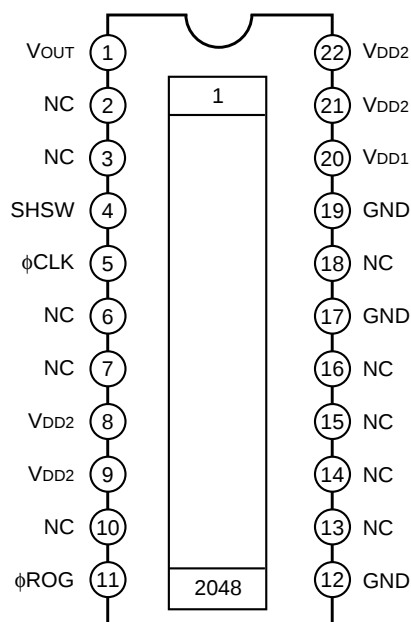
Features

- Number of effective pixels: 2048 pixels
- Pixel size: $14\mu\text{m} \times 14\mu\text{m}$ ($14\mu\text{m}$ pitch)
- Built-in timing generator and clock-drivers
- Ultra low lag
- Maximum clock frequency: 5MHz

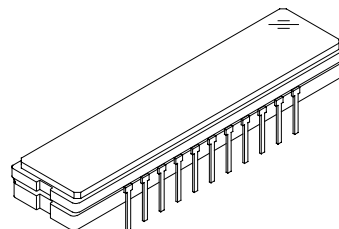
Absolute Maximum Ratings

- | | | | |
|-------------------------|------------------|------------|----|
| • Supply voltage | V _{DD1} | 11 | V |
| | V _{DD2} | 6 | V |
| • Operating temperature | | −10 to +55 | °C |
| • Storage temperature | | −30 to +80 | °C |

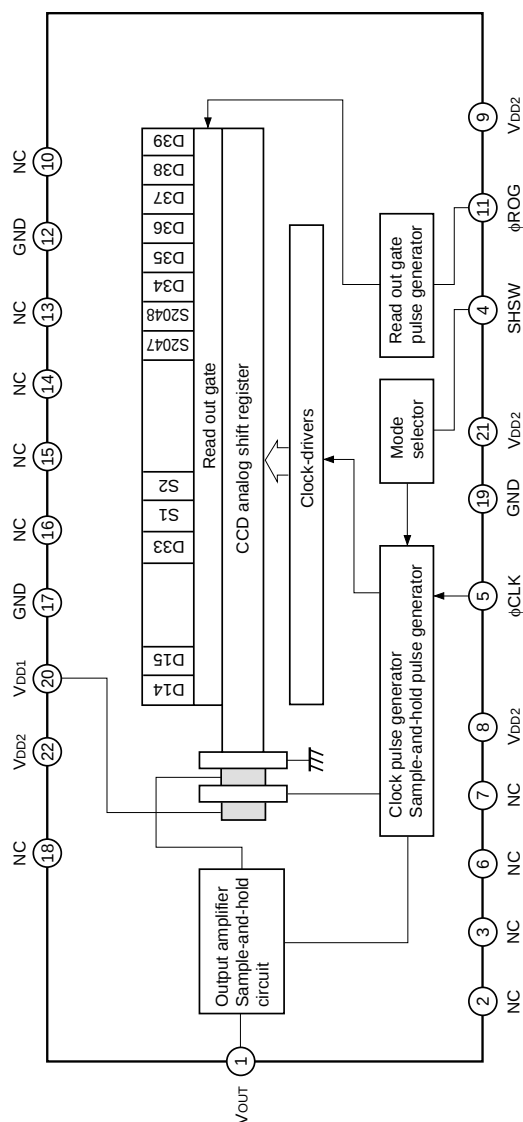
Pin Configuration (Top View)



22 pin DIP (Cer-DIP)



Block Diagram



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Pin Description

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	V _{OUT}	Signal output	12	GND	GND
2	NC	NC	13	NC	NC
3	NC	NC	14	NC	NC
4	SHSW	Switch { With S/H → GND Without S/H → V _{DD2}	15	NC	NC
5	φCLK	Clock pulse	16	NC	NC
6	NC	NC	17	GND	GND
7	NC	NC	18	NC	NC
8	V _{DD2}	5V power supply	19	GND	GND
9	V _{DD2}	5V power supply	20	V _{DD1}	9V power supply
10	NC	NC	21	V _{DD2}	5V power supply
11	φROG	Clock pulse	22	V _{DD2}	5V power supply

Recommended Supply voltage

Item	Min.	Typ.	Max.	Unit
V _{DD1}	8.5	9.0	9.5	V
V _{DD2}	4.75	5.0	5.25	V

Note) Rules for raising and lowering power supply voltage

To raise power supply voltage, first raise V_{DD1} (9V) and then V_{DD2} (5V).

To lower voltage, first lower V_{DD2} (5V) and then V_{DD1} (9V).

Mode Description

Mode in use	Pin condition
S/H	Pin 4 SHSW
Yes	GND
No	V _{DD2}

Input Capacity of Pins

Item	Symbol	Min.	Typ.	Max.	Unit
Input capacity of φCLK pin	C _{φCLK}	—	10	—	pF
Input capacity of φROG pin	C _{φROG}	—	10	—	pF

Recommended Input Pulse Voltage

Item	Min.	Typ.	Max.	Unit
Input clock high level	4.5	5.0	5.5	V
Input clock low level	0	—	0.5	V

Electro-optical Characteristics

(Ta = 25°C, V_{DD1} = 9V, V_{DD2} = 5V, Clock frequency = 1MHz, Light source = 3200K, IR cut filter: CM-500S (t = 1.0mm))

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Sensitivity	R	30	40	50	V/(lx · s)	Note 1
Sensitivity nonuniformity	PRNU	—	2.0	8.0	%	Note 2
Saturation output voltage	V _{SAT}	1.5	1.8	—	V	—
Dark voltage average	V _{DRK}	—	0.3	2.0	mV	Note 3
Dark signal nonuniformity	DSNU	—	0.5	3.0	mV	Note 3
Image lag	IL	—	0.02	—	%	Note 4
Dynamic range	DR	—	6000	—	—	Note 5
Saturation exposure	SE	—	0.045	—	lx · s	Note 6
9V supply current	I _{VDD1}	—	4.0	8.0	mA	—
5V supply current	I _{VDD2}	—	1.8	5.0	mA	—
Total transfer efficiency	TTE	92.0	97.0	—	%	—
Output impedance	Z _o	—	600	—	Ω	—
Offset level	V _{OS}	—	4.0	—	V	Note 7

Note)

- For the sensitivity test light is applied with a uniform intensity of illumination.
- PRNU is defined as indicated below. Ray incidence conditions are the same as for Note 1.

$$\text{PRNU} = \frac{(V_{\text{MAX}} - V_{\text{MIN}})/2}{V_{\text{AVE}}} \times 100 [\%]$$

The maximum output is set to V_{MAX}, the minimum output to V_{MIN} and the average output to V_{AVE}.

- Integration time is 10ms.

- V_{OUT} = 500mV

$$5. \text{ DR} = \frac{V_{\text{SAT}}}{V_{\text{DRK}}}$$

When optical accumulated time is shorter, the dynamic range gets wider because dark voltage is in proportion to optical accumulated time.

$$6. \text{ SE} = \frac{V_{\text{SAT}}}{R}$$

- V_{OS} is defined as indicated below.

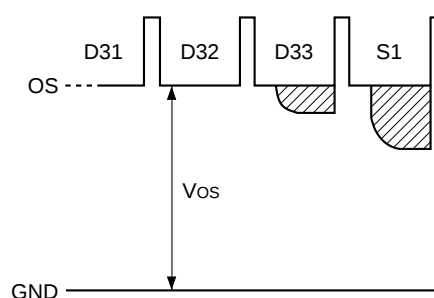


Fig.1. Clock Timing Diagram (without S/H mode)

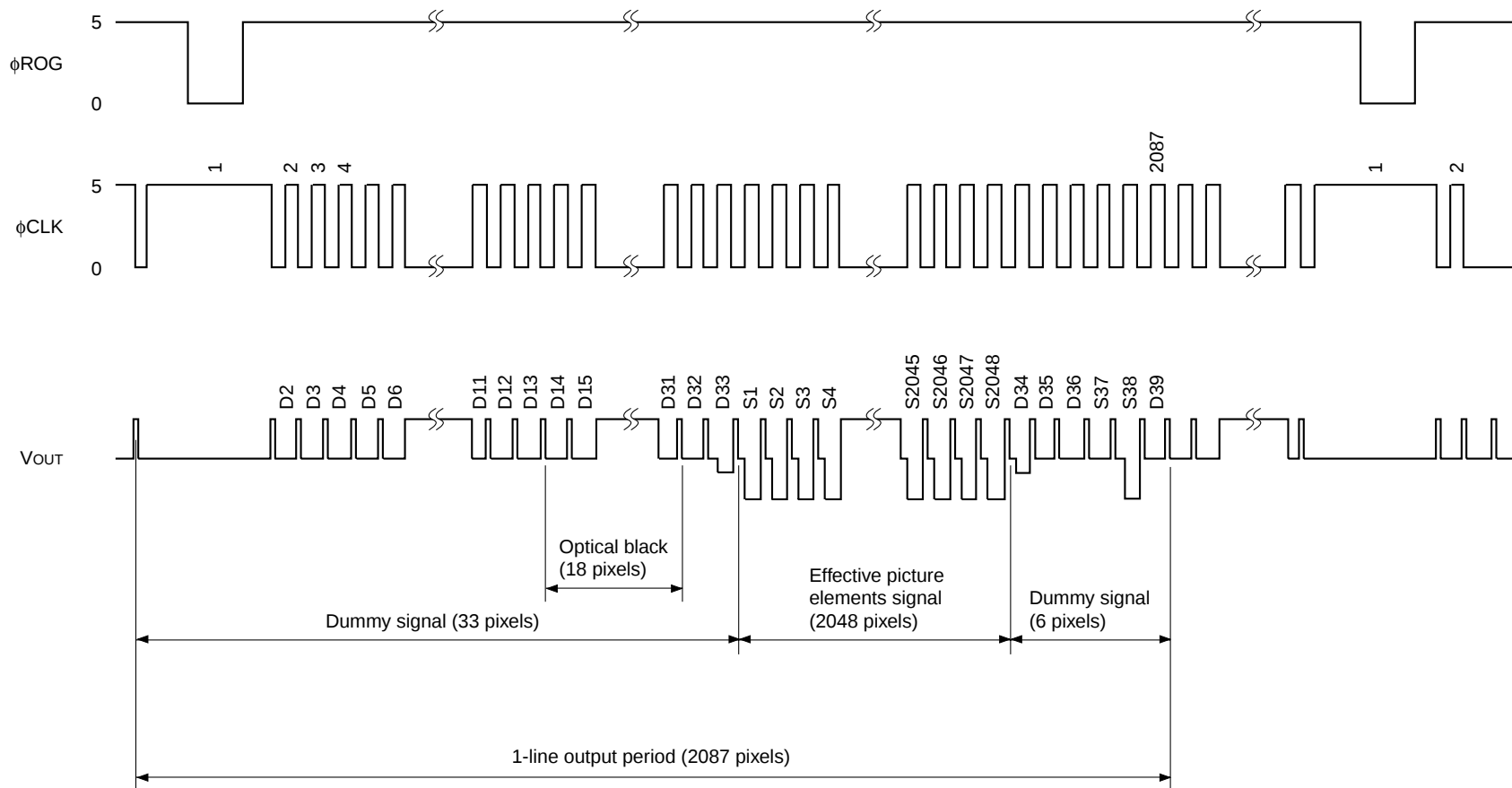
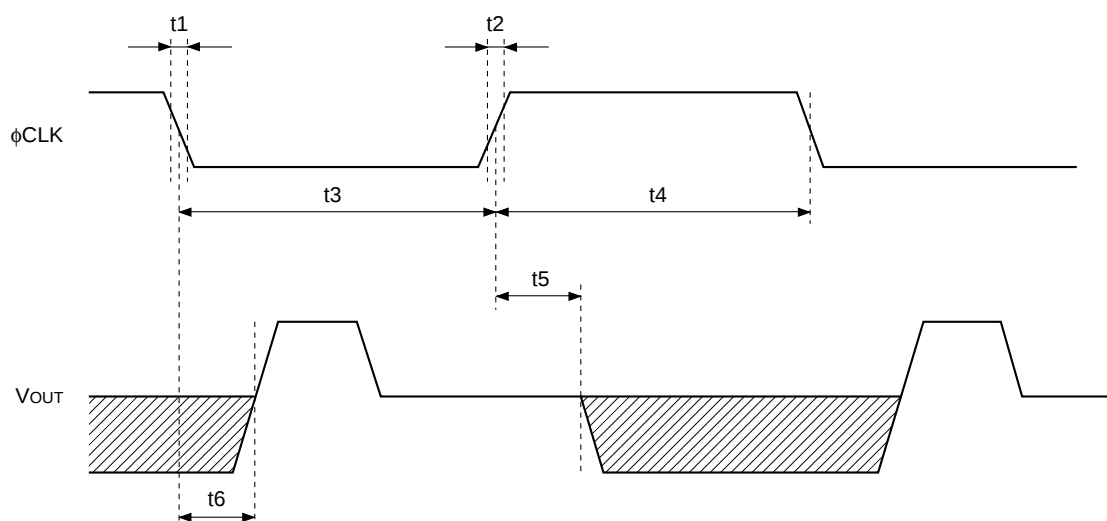
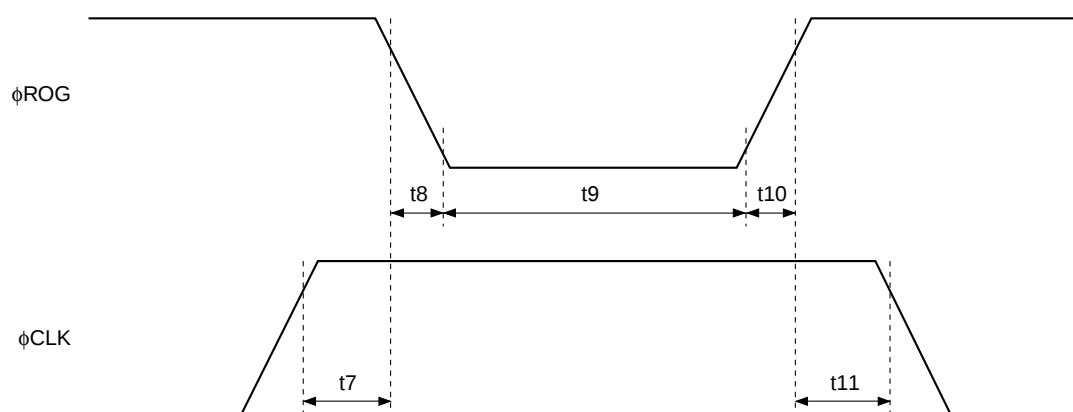


Fig. 2. ϕCLK , V_{OUT} Timing

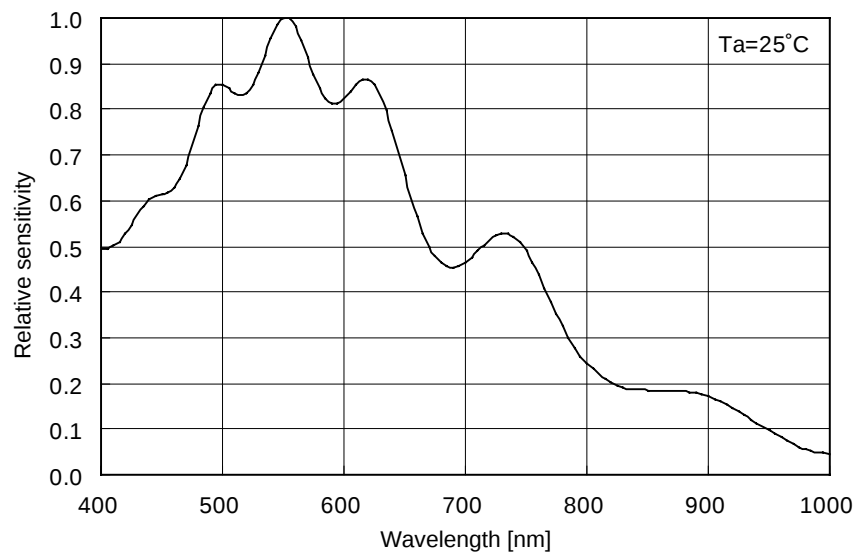
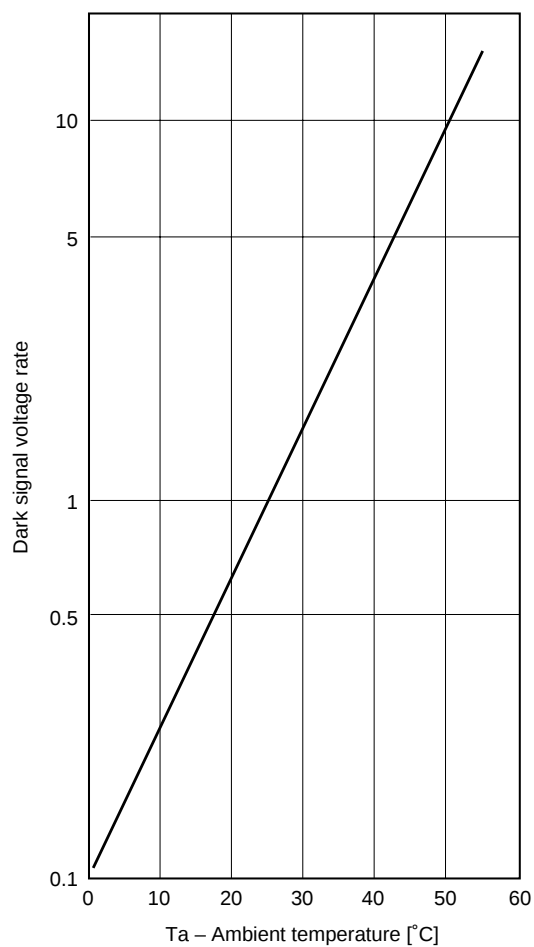
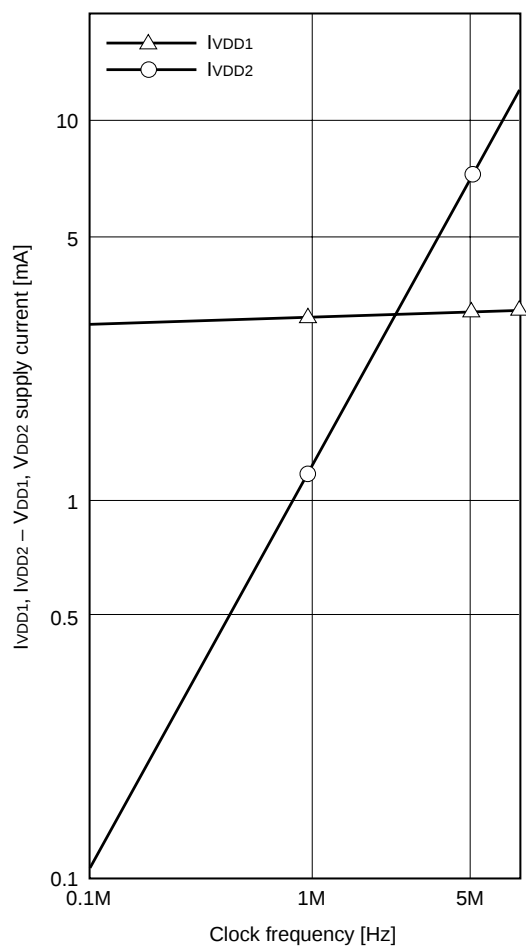
Item	Symbol	Min.	Typ.	Max.	Unit
ϕCLK pulse rise/fall time	t_1, t_2	0	10	—	ns
ϕCLK pulse duty ^{*1}	—	40	50	60	%
$\phi\text{CLK} - V_{\text{OUT}1}$	t_5	50	80	110	ns
$\phi\text{CLK} - V_{\text{OUT}2}$	t_6	30	75	120	ns

^{*1} $100 \times t_3 / (t_3 + t_4)$

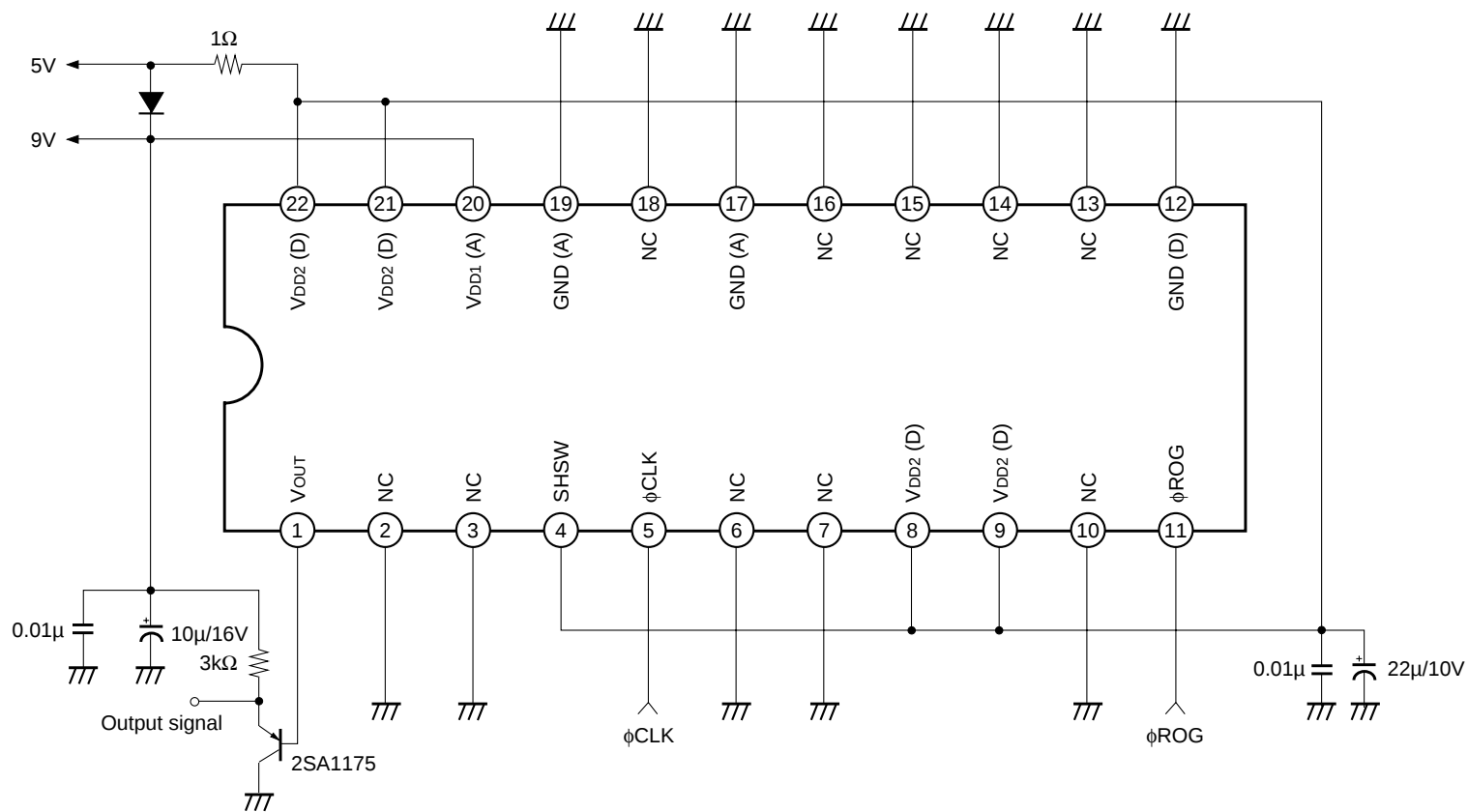
Fig. 3. ϕROG , ϕCLK Timing

Item	Symbol	Min.	Typ.	Max.	Unit
ϕROG , ϕCLK pulse timing	t_7, t_{11}	500	1000	—	ns
ϕROG pulse rise/fall time	t_8, t_{10}	0	10	—	ns
ϕROG pulse period	t_9	500	1000	—	ns

Example of Representative Characteristics

Spectral sensitivity characteristics
(Standard characteristics)Dark signal voltage rate vs. Ambient temperature
(Standard characteristics)VDD1, VDD2 supply current vs. Clock frequency
(Standard characteristics)

Application Circuit



Application circuits shown are typical examples illustrating the operation of the devices. Sony cannot assume responsibility for any problems arising out of the use of these circuits or for any infringement of third party patent and other right due to same.

Notes on Handling

1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling, be sure to take the following protective measures.

- Either handle bare handed or use non-chargeable gloves, clothes or material. Also use conductive shoes.
- When handling directly use an earth band.
- Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- Ionized air is recommended for discharge when handling CCD image sensors.
- For the shipment of mounted substrates use cartons treated for the prevention of static charges.

2) Notes on handling CCD Cer-DIP package

The following points should be observed when handling and installing Cer-DIP packages.

- Remain within the following limits when applying static load to the ceramic portion of the package:

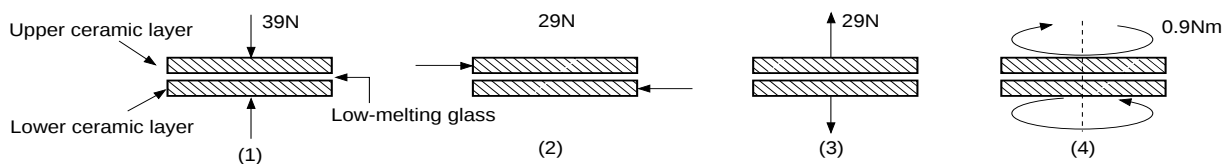
- (1) Compressive strength: 39N/surface

(Do not apply load more than 0.7mm inside the outer perimeter of the glass portion.)

- (2) Shearing strength: 29N/surface

- (3) Tensile strength: 29N/surface

- (4) Torsional strength: 0.9Nm



- In addition, if a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the ceramic portion. Therefore, for installation, either use an elastic load, such as a spring plate, or an adhesive.

- Be aware that any of the following can cause the glass to crack because the upper and lower ceramic layers are shielded by low-melting glass.

- (1) Applying repetitive bending stress to the external leads.
- (2) Applying heat to the external leads for an extended period of time with a soldering iron.
- (3) Rapid cooling or heating.
- (4) Rapid cooling or impact to a limited portion of the low-melting glass with a small-tipped tool such as tweezers.
- (5) Prying the upper or lower ceramic layers away at a support point of the low-melting glass.

Note that the preceding notes should also be observed when removing a component from a board after it has already been soldered.

3) Soldering

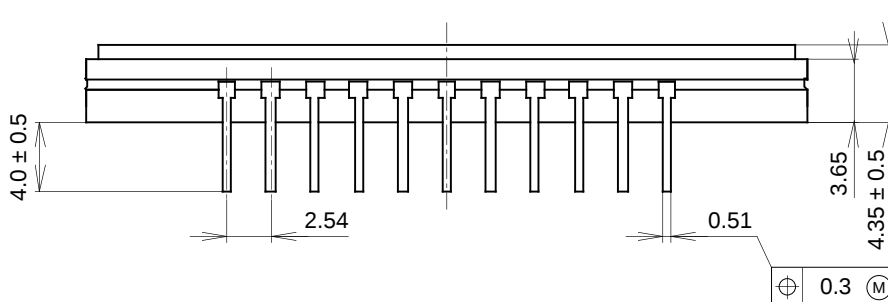
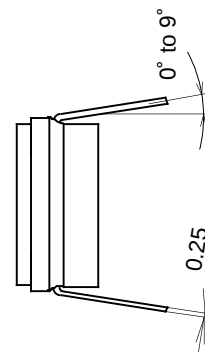
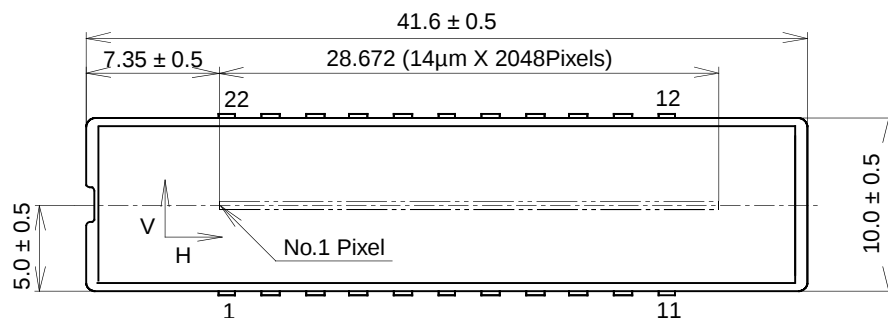
- Make sure the package temperature does not exceed 80°C.
- Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a 30W soldering iron with a ground wire and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- To dismount image sensors, do not use a solder suction equipment. When using an electric desoldering tool, ground the controller. For the control system, use a zero cross type.

- 4) Dust and dirt protection
 - a) Operate in clean environments.
 - b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface blow it off with an air blower. (For dirt stuck through static electricity, ionized air is recommended.)
 - c) Clean with a cotton bud and ethyl alcohol if the glass surface is grease stained. Be careful not to scratch the glass.
 - d) Keep in case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- 5) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.
- 6) CCD image sensors are precise optical equipment that should not be subject to mechanical shocks.

Package Outline

Unit: mm

22 pin DIP (400mil)



1. The height from the bottom to the sensor surface is 2.45 ± 0.3 mm.
2. The thickness of the cover glass is 0.7 mm, and the refractive index is 1.5 .

PACKAGE STRUCTURE

PACKAGE MATERIAL	Cer-DIP
LEAD TREATMENT	TIN PLATING
LEAD MATERIAL	42 ALLOY
PACKAGE MASS	5.20g
DRAWING NUMBER	LS-A18-01(E)